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Gradient-based Sharpness Function

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Abstract—Most autofocus methods are based on a sharpness function which delivers a real-valued estimate of an image quality. In this paper we study an $L_2$-norm gradient-based sharpness function for two-dimensional images (2-D setting). Within this setting we are able to take into account the asymmetry of the optical device objective lens (astigmatism aberration). This study provides a useful extension of the analytical observations for one-dimensional images (1-D setting) that have been done before. The gradient-based autofocus method is implemented and demonstrated for the real-world application running in the FEI scanning transmission electron microscope prototype.

Index Terms—Defocus, autofocus, astigmatism, sharpness function, gradient

I. INTRODUCTION

An image obtained with an optical device, such as a photocamera, a telescope or a microscope, depends on a given object’s geometry, known as the object function, and the optical device control variables (for instance, defocus). The method of automatic defocus determination, such that the recorded image is in-focus, is known as autofocus method. In this paper we use the low resolution scanning transmission electron microscopy (STEM) as a reference application for our method. The magnetic lenses in the electron microscope usually suffer from astigmatism aberration (the objective lens is not rotationally symmetric). Astigmatism is controlled by two stigmator control variables. The method of automatic determination of stigmator values is known as automated astigmatism correction. Nowadays STEM still requires an expert operator to trigger recording of in-focus and astigmatism-free images using a visual feedback [1].

The existing autofocus methods used for different types of optical devices are usually based on a sharpness function, a real-valued estimate of the image’s sharpness. For a through-focus series an ideal sharpness function should reach a single optimum at the in-focus image. Existing sharpness functions are based on the image derivatives [2], variance [3], [4], autocorrelation [5], histogram [6] or Fourier transform [7]. An overview of these functions can be found in [8], [9]. A sharpness function can be also used for simultaneous defocus and astigmatism correction if it is optimized in the three-parameter space [4], [10]. Also the sharpness functions are used for the study of hysteresis in electromagnetic lenses [11].

In this paper we study a gradient-based sharpness function. The advantage of using this function is demonstrated experimentally for different optical devices [6], [8], [9], [12]. It has been shown analytically for the 1-D setting that for the noise-free image formation the $L_2$-norm derivative-based sharpness function reaches its unique optimum for the in-focus image. Moreover under certain assumptions the function can accurately be approximated by a quadratic polynomial [13]. In this paper the study is extended to the 2-D setting. Only within this setting we can take into account the influence of the astigmatism on the sharpness function. The method is implemented in a FEI STEM and is demonstrated for a real-world microscopy application.

The paper is set up as follows: Section II explains the image formation modelling. Section III formulates the process of automated correction. The theoretical observations on the gradient-based sharpness function are given. Section IV presents the results of the on-line autofocus correction method implemented and running on a FEI STEM prototype.

II. MODELLING

In Subsection II-A of this section we describe notation and conventions used in this paper. The work principle of defocus and stigmator control variables is explained in Subsection II-B. Subsequently, Subsection II-C provides the model for the point spread function and relates its characteristics to the control variables. Finally, the models for the image formation and the object geometry are explained in subsections II-D, II-E respectively.

A. Notation and conventions

The 2-D spatial and frequency coordinates are denoted as $x := (x, y)^T$, $u := (u, v)^T \in \mathbb{R}^2$ respectively. For a vector $w := (w_i)_{i=1}^N$ we define $w^p := (|w_i|^p)_{i=1}^N$, $|w| := (\sum_i |w_i|^2)^{1/2}$. The $L_2$-norm of a function is defined as

$$
\|f\|_{L_2} := \left( \int_{-\infty}^{\infty} |f|^2 \, dx \right)^{1/2},
$$

and $L_2(\mathbb{R}^2)$ is the space of functions with finite $L_2$-norm. The Fourier transform $\hat{f}$ of a function $f \in L_2(\mathbb{R}^2)$ plays a fundamental role in our analysis and modeling

$$
\hat{f}(f(x))(u) := \hat{f}(u) := \int_{-\infty}^{\infty} f(x)e^{-iu \cdot x} \, dx,
$$

where $\cdot$ denotes the vector inner product. The rotation operator $R_\theta : L_2(\mathbb{R}^2) \rightarrow L_2(\mathbb{R}^2)$ is defined by $R_\theta f(x) := f(R_\theta x)$ where $R_\theta$ is the rotation matrix

$$
R_\theta := \begin{pmatrix} \cos \theta & -\sin \theta \\ \sin \theta & \cos \theta \end{pmatrix},
$$

and the stretching matrix is defined as follows

$$
Q_\zeta := \begin{pmatrix} \zeta & 0 \\ 0 & 1/\zeta \end{pmatrix}.
$$
The vector of the ideal control variables values (the setting of the \( B \) field generated by \( A \)) are used (Figure 2(a)). They produce the electromagnetic field for the correction of the ellipticity of the electron beam \([15]\). Currents of the same magnitude go through coils \( A_k \) (\( k = 1, \ldots, 4 \)). The field generated by \( A_k \) influences the rays traveling along two orthogonal axes \( A_l \) (\( l = 1, 2 \)). Similarly, the field generated by \( B_k \) influences the stretching along axes \( B_l \), see also \([14]\). The angle between \( A_1 \) and \( B_1 \) is always \( \frac{\pi}{2} \). The magnitude and direction of the current through coils \( A_k \) are controlled by the stigmator control variable \( d_k \), through \( B_k \) - control variable \( d_l \).

We will deal with the vector of three control variables

\[
d := (d, d_k, d_l)^T.
\]

The vector of the ideal control variables values (the setting when the output image has the highest possible quality) is defined as

\[
d_0 := (d_0, d_{k_0}, d_{l_0})^T.
\]

Let \( \varphi \in L_2(\mathbb{R}^2) \) be the point spread function (PSF), the function that describes the shape of electron beam. By adjusting the machine controls we obtain

\[
\varphi = C \varphi(T_d x),
\]

\[
T_d := \frac{1}{d - d_0} Q_{d-x-d_{k_0}+1} R_{\pi/4} Q_{d_{k_0}-d_{l_0}+1} R_{-\pi/4}.
\]

In (5) \( C \) is the normalization constant such that after the transformation the PSF still satisfies \( \int_{-\infty}^{\infty} \varphi(x) dx = 1 \). In (5) defocus \( d \) is proportional to the PSF width, \( Q_{d-x-d_{k_0}} \) controls the stretching in the horizontal and vertical directions, \( R_{\pi/4} Q_{d_{k_0}-d_{l_0}+1} R_{-\pi/4} \) controls the stretching in the diagonal directions.

### B. Optical device control variables

Figure 1(a) shows the ray diagram, where the objective lens has one focal point \( F \). The only adjustable parameter is the current through the magnetic lens; it changes the lens focal length and focuses the magnetic beam on the image plane \([14]\). The current is adjusted with the defocus control variable \( d \). Astigmatism implies that the rays traveling through a horizontal plane and the rays traveling through a vertical plane will meet at different focal points (\( F_1 \) and \( F_2 \) in Figure 1(b)). Thus, the image cannot be totally sharp.

For astigmatism correction in electron microscopy, electromagnetic or electromagnetic stigmators are used (Figure 2(a)). They produce the electromagnetic field for the correction of the ellipticity of the electron beam \([15]\). Currents of the same magnitude go through coils \( A_k \), while currents of a different magnitude go through coils \( B_k \) (\( k = 1, \ldots, 4 \)). The field generated by \( A_k \) influences the rays traveling along two orthogonal axes \( A_l \) and the field generated by \( B_k \) influences the stretching along axes \( B_l \), see also \([14]\). The angle between \( A_1 \) and \( B_1 \) is always \( \frac{\pi}{2} \). The magnitude and direction of the current through coils \( A_k \) are controlled by the stigmator control variable \( d_k \), through \( B_k \) - control variable \( d_l \).

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### C. Point spread function

The PSF can accurately be approximated by a Lévi stable density function for a wide class of optical devices \([16], [17]\). The Lévi stable density function is implicitly defined via its Fourier transform in 1-D as follows

\[
\hat{\varphi}_\sigma(\omega) := e^{-\sigma^2 \omega^\beta/2}, \quad 0 < \beta \leq 1.
\]

The parameter \( \beta \) in (6) depends on the optical device. If \( \beta = 1 \) in (6), the PSF is a Gaussian function. The parameter \( \sigma \) in (8) is known as the width of the PSF. In 1-D setting it is simply related to the defocus control variable \( d \)

\[
\sigma = d - d_0,
\]

where \( d_0 \) is unknown. In real-world applications \( d \neq d_0 \) due to the physical limitations of the objective lens, thus the PSF width is never equal to zero.

Due to the presence of astigmatism the PSF in 2-D setting is not always rotationally symmetric. To find a 2-D PSF we consider a tensor product of 1-D functions in \( x \) and \( y \) directions taking into account the possibility of system rotation with the angle \( \theta \)

\[
\hat{\varphi}_\sigma(\mathbf{u}) := e^{-\frac{1}{2}|(R_\theta J_\sigma \mathbf{u})|^2},
\]

\[
\mathbf{J}_\sigma := \begin{pmatrix} \sigma - \varsigma & 0 \\ 0 & \sigma + \varsigma \end{pmatrix}, \quad (8)
\]

For the Fourier transform it trivially follows that

\[
\hat{\mathcal{F}}[\varphi(R\mathbf{x})](\mathbf{u}) := \int_{-\infty}^{\infty} \varphi(R\mathbf{x}) e^{-i \mathbf{u} \cdot \mathbf{x}} d\mathbf{x} = \frac{1}{|\det R|} \int_{-\infty}^{\infty} \varphi(y) e^{-i (R^{-T} \mathbf{u}) y} dy = \frac{1}{|\det R|} \hat{\varphi}(R^{-T} \mathbf{u}).
\]

Therefore the rotation angle \( \theta \) of the PSF in Fourier space is equal to the rotation angle of the PSF in the real space

\[
\hat{\mathcal{F}}[R_\theta \varphi] = R_\theta \hat{\varphi}.
\]

Figure 2(b) shows a schematic representation of such an elliptic PSF. If \( \varsigma = 0 \) in (8) the astigmatism is not present, and the PSF is rotationally symmetric. If astigmatism is present (\( \varsigma \neq 0 \)), and at the same time \( \sigma = 0 \) (i.e. the image is in-focus), the PSF is symmetric with the width \( \varsigma \), which means that the image is not totally sharp.

For the suggested model we can easily find the relation between PSF parameters and control variables

\[
\sigma = \frac{d - d_0}{\sqrt{2(d_y - d_{y_0} + 1)^2 + \frac{\alpha^2}{(d_x - d_{x_0} + 1)^2}}},
\]

\[
\varsigma = \frac{d - d_0}{\sqrt{2(d_y - d_{y_0} + 1)^2 + \frac{\alpha^2}{(d_x - d_{x_0} + 1)^2}}},
\]

\[
\theta = \arccos \left( \frac{(d_y - d_{y_0} + 1)^2 + 1}{\sqrt{2(d_y - d_{y_0} + 1)^2 + 2}} \right).
\]
D. Linear image formation model

Images for which our sharpness function will be computed are the output images $f \in L_2(\mathbb{R}^2)$ of the so-called image formation model represented by Figure 2(c). The object’s geometry (or the object function) is described by $\rho$. The filter $g_\sigma$ describes the PSF of an optical device.

The output of the $g_\sigma$ filter is denoted by $f_0$ and is often post-processed by a PC. We assume that in such post-processing a Gaussian filter $g_\sigma(x) := \frac{1}{\sqrt{\pi \sigma^2}} e^{-\frac{x^2}{\sigma^2}}$ is applied to the image $f_0$. Filtering with a Gaussian kernel is often used for denoising purposes, which is an easy alternative to more advanced techniques [18], [19], [20]. It has been shown that the control variable $\alpha$ is useful not only for denoising the image $f_0$; it also influences the approximation error when the sharpness function is replaced by a quadratic polynomial [13]. The value of $\alpha$ is fixed during the autofocus process.

We apply the linear image formation model, which is often used for different optical devices [2], in particular for electron microscopes [3]. In this paper we consider low-to-medium magnification of the electron microscope (resolution higher or equal to 1 nm), thus the image formation can be approximated with this model [21]. This implies that the occurring filters are linear and space invariant which can easily be described by means of convolution products

$$f_0 := \psi * g_\sigma, \quad f := f_0 * g_\sigma. \quad (9)$$

If no post-processing is applied, $\alpha = 0$, and $f = f_0$.

E. Object function

We assume that the object function satisfies

$$\int_{-\infty}^{\infty} |\psi(x)| dx < \infty. \quad (10)$$

In practice this will easily be satisfied because the function $\psi$ has a finite domain, i.e., the image has a finite size. As a consequence $\psi$ is bounded and continuous.

In classical signal analysis a discrete signal $\psi$ is modelled as a finite linear combination of delta functions

$$\psi(x) = \sum_{k,l=1}^{K} a_{k,l} \delta(x - \tau k), \quad k := (k,l)^T, \quad \tau > 0. \quad (11)$$

We consider the image with a finite number of pixels $a_{k,l}$, i.e. $K < \infty$. In this case $\psi$ is a tri-geometric polynomial which again is bounded and smooth.

Property 1. The power spectrum of the object function (11) can be expressed as

$$|\hat{\psi}(u)|^2 = \sum_{n,m} \rho_{n,m} e^{i\pi n u}, \quad n := (n,m)^T, \quad (12)$$

where

$$\rho_{n,m} := \sum_{k,l} a_{k,l} a_{n+k,m+l}, \quad (13)$$

are the autocorrelation coefficients of the pixel values.

Proof: The proof is analogue to the 1-D case [13].

As a special example of an object function consider

$$|\hat{\psi}(u)|^2 = C e^{-|u|^2 \gamma^2}, \quad C > 0, \quad \gamma > 0. \quad (14)$$

Such images, for $\gamma > 0$, often occur in real-world applications from single particles. For $\gamma = 0$ in (14), $|\psi|^2$ is constant, which corresponds to the situation when the object is nearly amorphous [3].

III. GRADIENT-BASED SHARPNESS FUNCTION

The existing autofocus methods used for different types of optical devices are usually based on a sharpness function $S : L_2(\mathbb{R}^2) \rightarrow \mathbb{R}$, a real-valued estimate of the image’s quality. For a through-focus series of images the sharpness function is computed for different values of $d$ given a fixed value of $\alpha$. A general behaviour of a sharpness function is shown in Figure 2(d). The image at the defocus $d = d_0$ is sharp or in-focus and the sharpness function reaches its optimum. The image far away from $d_0$ is called out-of-focus.

For simultaneous defocus and astigmatism correction stigmator controls are adjusted as well, and the goal is to estimate $d_0$ from the values of the sharpness function computed at different points.

In this section we provide the general properties of the gradient-based sharpness function

$$S := \left| \nabla f \right|^2. \quad (15)$$

Property 2. If $f$ is given by (9) with the PSF (7) then the sharpness function (15) can be written as follows

$$S(\sigma) = \frac{1}{2\pi} \int_{-\infty}^{\infty} |u|^2 |\hat{\psi}(u)|^2 e^{-|R_{\sigma} \hat{\psi}(u)|^2} e^{-|u|^2 \sigma^2} du. \quad (16)$$

Proof: Because of Parseval’s identity we have

$$S(\sigma) = \frac{1}{2\pi} \int_{-\infty}^{\infty} |u|^2 |\hat{\psi}(u)|^2 |\hat{g}_\sigma(u)|^2 |\hat{g}_\sigma(u)|^2 du.$$
A. Rotationally symmetric PSF

In the corollaries, the property and the theorem below we first consider the sharpness function (15) for the rotationally symmetric PSF, \( \zeta = 0 \) in (8)).

**Corollary 1.** The sharpness function can be expressed as

\[
S(\sigma) = \frac{1}{2\pi} \int_{-\infty}^{\infty} |u|^2 \tilde{\phi}(u) e^{-\sigma^2 |u|^2} e^{-|u|^2 \alpha^2} du.
\] (17)

**Corollary 2.** The sharpness function is smooth, and is strictly increasing for \( \sigma < 0 \) and strictly decreasing for \( \sigma > 0 \).

**Corollary 3.** The sharpness function has a finite maximum at \( \sigma = 0 \) for \( \alpha > 0 \); in particular \( \max_\sigma S(\sigma) = S(0) \).

It follows that the basic properties of the gradient-based sharpness function in 2-D are similar to the properties in 1-D [13], if we consider a rotationally symmetric PSF: for the noise free image formation the function has a unique optimum at the in-focus image. Further we consider the Gaussian PSF (\( \beta = 1 \) in (7)).

**Property 3.** The sharpness function \( S \) can be expressed by means of the autocorrelation coefficients (13) as follows

\[
S(\sigma) = \frac{1}{2\pi(\sigma^2 + \alpha^2)^2} \sum_{n,m} \rho_{n,m} \int_{-\infty}^{\infty} |u|^2 e^{\frac{in\pi \rho_{n,m}}{\sqrt{\sigma^2 + \alpha^2}} e^{-|u|^2 \alpha^2}} du.
\] (18)

**Proof:** After we rewrite the sharpness function (17)

\[
S(\sigma) = \frac{1}{2\pi(\sigma^2 + \alpha^2)^2} \int_{-\infty}^{\infty} |u|^2 \tilde{\phi}(\frac{u}{\sqrt{\alpha^2 + \sigma^2}}) e^{-|u|^2} du.
\]

and substitute the expression for the power spectrum (12), we achieve (18).

**Theorem 1.** The sharpness function can be expressed as

\[
S(\sigma) = \frac{C_1}{2\pi(\alpha^2 + \sigma^2)^2} (1 + R_1(\sigma)),
\] (19)

where

\[
|R_1(\sigma)| \leq K_1 \frac{\tau}{\sqrt{\alpha^2 + \sigma^2}},
\] (20)

and \( C_1, K_1 \) depend only on the pixel values \( a_{k,t} \).

**Proof:** Splitting \( e^{\frac{in\pi \rho_{n,m}}{\sqrt{\sigma^2 + \alpha^2}}} \) into \( (e^{\frac{in\pi \rho_{n,m}}{\sqrt{\sigma^2 + \alpha^2}}} - 1) + 1 \) in (18), one obtains

\[
S(\sigma) = \frac{1}{2\pi(\sigma^2 + \alpha^2)^2} \left( \int_{-\infty}^{\infty} |u|^2 e^{-|u|^2} du \right) \sum_{n,m} \rho_{n,m} + C_1 \int_{-\infty}^{\infty} |u|^2 e^{-|u|^2} \sum_{n,m} \rho_{n,m} (e^{\frac{in\pi \rho_{n,m}}{\sqrt{\sigma^2 + \alpha^2}}} - 1) du.
\] (21)

It trivially follows that

\[
C_1 = \int_{-\infty}^{\infty} |u|^2 e^{-|u|^2} du \sum_{n,m} \rho_{n,m} = \pi \sum_{n,m} \rho_{n,m}.
\]

To estimate \( R_1 \) observe that

\[
|e^{i\eta} - 1| = 2|\sin \frac{\eta}{2}| \leq |\eta|, \quad \eta \in \mathbb{R},
\] (22)

for \( \eta = \frac{\pi n\rho_{n,m}}{\sqrt{\alpha^2 + \sigma^2}} \), and consequently

\[
\left| \sum_{n,m} \rho_{n,m} (e^{\frac{in\pi \rho_{n,m}}{\sqrt{\alpha^2 + \sigma^2}}} - 1) \right| \leq \frac{\tau}{\sqrt{\alpha^2 + \sigma^2}} \left( \sum_{n,m} |\rho_{n,m}| + \sum_{n,m} |m| \rho_{n,m} \right).
\] (23)

It follows

\[
\left| \int_{-\infty}^{\infty} |u|^2 e^{-|u|^2} \sum_{n,m} \rho_{n,m} (e^{\frac{in\pi \rho_{n,m}}{\sqrt{\alpha^2 + \sigma^2}}} - 1) du \right| \leq \frac{3\sqrt{\pi}}{2} \frac{\tau}{\sqrt{\alpha^2 + \sigma^2}} \sum_{n,m} (|n| + |m|) \rho_{n,m}.
\]

Then the statement of the theorem is straightforward with

\[
K_1 = \frac{3}{2\sqrt{\pi}} \frac{\tau}{\sqrt{\alpha^2 + \sigma^2}} \sum_{n,m} (|n| + |m|) \rho_{n,m}.
\]

It follows from (19) that the function \( S^{-1/2}(\sigma) \) can be approximated with any accuracy by a quadratic polynomial by increasing the value of the control variable \( \alpha \). This also corresponds to the findings made for the 1-D setting before. The only difference is the power of the sharpness function to be taken for a quadratic approximation. Below we examine a more general case of a non-symmetric PSF.

B. Non-symmetric PSF

**Property 4.** Image rotation does not influence the sharpness function, i.e.

\[
S[R_\theta f] = S[f].
\]

**Proof:** Rotation transformation is just a linear transformation of the coordinates, which satisfies the properties \( \det R_\theta = 1 \), \( R_\theta^T = R_\theta \), thus

\[
S[R_\theta f] = \| \frac{\partial}{\partial x} R_\theta f \|_{L_2} = \| R_\theta \frac{\partial}{\partial x} f \|_{L_2} = \frac{1}{\det R_\theta} \| \frac{\partial}{\partial x} f \|_{L_2}.
\]

**Corollary 4.** For the linear image formation model, the rotation of the PSF does not influence the sharpness function

\[
S[\psi * R_\theta g_\sigma * g_\alpha] = S[\psi * g_\sigma * g_\alpha].
\]

For further simplification of our analysis we make therefore a general assumption \( \theta = 0 \) in (16). In these case the adjustment of stigmator \( d_\theta \) is not necessary. Neglecting the PSF rotation angle does not limit the theoretical observations. However, in real-world applications defocus and astigmatism correction still remain a three-parameter problem. It has not been possible so far to implement PSF rotation directly in the hardware; thus its elliptic form can be adjusted only by a combination of the two stigmator control variables.

**Property 5.** For the object function (14) and the Gaussian PSF, the sharpness function (15) is given by

\[
S(\sigma) = \frac{C(\zeta^2 + \sigma^2 + \alpha^2 + \gamma^2)}{2(\zeta^2 + \sigma^2 + \alpha^2 + \gamma^2)^{3/2}}.
\] (24)
Figure 3 shows functions (24) computed for $\alpha = 0, \gamma = 0$ for different values of $\varsigma$. For $\varsigma = 0$ the function has a unique optimum at $\sigma = 0$. For $\varsigma > 0$ the function has a minimum instead of maximum at the in-focus position and two local maxima at $\sigma_1, 2$. This benchmark example is important, because it shows that due to the presence of astigmatism a standard autofocus procedure might fail. For a larger value the distance between the optima decreases, and their amplitudes are smaller (Figure 4). If $\sqrt{\alpha^2 + \gamma^2} \geq \sqrt{2}\varsigma$ the sharpness function has a maximum at $\sigma = 0$ and does not have any other optima.

The sharpness function improvement with the help of $\alpha$ adjustments has been shown before experimentally for an electron microscopy through-focus series with local optima due to the astigmatism presence ([13], page 13, Figure 7). The benchmark case, which we studied in this subsection gives a theoretical insight into this effect.

**Property 6.** For the object function (14) and the Gaussian PSF the sharpness function in the two-parameter space $S = S(\sigma)$ has a maximum at $\sigma = (0, 0)^T$ and does not have any other optimum.

**Proof:** It is easy to find that partial derivatives of the function (24)

$$\frac{\partial}{\partial \sigma} S(0, 0) = \frac{\partial}{\partial \varsigma} S(0, 0) = 0.$$ 

Further it is clear that for $\varsigma \in \mathbb{R}$, $\frac{\partial}{\partial \varsigma} S(\sigma_k, \varsigma) \neq 0$, $k = 1, 2$. 

Figure 4 shows the sharpness function shape in a two-parameter space computed for $\alpha = 0.1$ and $\alpha = 2$. In both cases the sharpness function has a maximum as $\sigma = (0, 0)^T$ and does not have any other optima. This is convenient for simultaneous defocus and astigmatism correction, which could be done by optimizing the sharpness function in two-parameter space [4], [10]: the local optima that the sharpness function obtains in 1-D are not optima anymore in higher dimensions. This funding coincide with the results of the sharpness function behaviour obtained via simulations of the variance-based sharpness function [4]. Still, tuning the artificial blur $\alpha$ make the shaper of the sharpness function closer to convex, which might increase the speed of optimization.

Corollary below directly follows from Property 2.

**Corollary 5.** For the Gaussian object function and the symmetric Gaussian PSF ($\varsigma = 0$) the sharpness function (15) is given by

$$S(\sigma) = \frac{C}{2(\sigma^2 + \alpha^2 + \gamma^2)^2}.$$ 

In this case the sharpness function to the power $-1/2$ is a quadratic polynomial

$$S^{-1/2} (d - d_0) = \frac{1}{\sqrt{C}} \sqrt{(d - d_0)^2 + \alpha^2 + \gamma^2}.$$ 

is a quadratic polynomial, which is coincides with the observations of Theorem 1, which are made for a more general case.

**IV. AN AUTOMATIC AUTOFOCUS ALGORITHM FOR A REAL-WORLD APPLICATION**

A detailed description of the gradient-based fast autofocus method can be found in [13]. Here we just provide a short overview of the autofocus algorithm:

1. Let $d_2$ be the current defocus control value. Choose $\Delta d$, then $d_1 := d_2 - \Delta d$, $d_3 := d_2 - \Delta d$.
2. Obtain three images at $d_1, d_2, d_3$ and compute $S_1, S_2, S_3$. We set $\mathcal{N} = 3$.
3. We fit $\mathcal{N}$ given points with a quadratic polynomial

$$P(d) := c_0 + c_1d + c_2d^2.$$ 

For $\mathcal{N} > 3$ we obtain the overdetermined system

$$
\begin{pmatrix}
1 & d_1 & d_1^2 \\
1 & d_2 & d_2^2 \\
1 & d_3 & d_3^2 \\
\vdots & \ldots & \ldots \\
1 & d_{N} & d_{N}^2
\end{pmatrix}
\begin{pmatrix}
c_0 \\
c_1 \\
c_2
\end{pmatrix}
= 
\begin{pmatrix}
S_1 \\
S_2 \\
S_3 \\
\vdots \\
S_{N}
\end{pmatrix}.
$$
This can e.g. be solved by least squares, giving
\[ D^T D c = D^T s, \]
compute \( c \); estimate the sharpness function optimum
\[ d_{N+1} = -\frac{c_1}{2c_2}, \]
as the optimum of the polynomial
4) If for the given tolerance \( |d_N - d_{N+1}| < d_{tol} \), stop.
Else, compute \( S_{N+1} = S(d_{N+1}) \) and go to the previous step.

More iterations (N > 3) are required only if a very accurate focusing is needed. In step three different numerical methods could be used. The choice of the method is not quite significant for small N. For a proper choice of \( \alpha \) it can be possible to extend the algorithm to simultaneous autofocus and astigmatism correction by fitting the sharpness function with a quadratic polynomial in a higher dimension.

The autofocus method is implemented in a prototype FEI Tecnai F20 STEM. One example of an application run is shown in Figure 5. The initial position of the machine defocus is \( d_1 = -3 \, \mu m \). The defocus step \( \Delta d = 5 \, \mu m \) is chosen. The two intermediate images with \( d_2 = -8 \, \mu m \) and \( d_3 = 2 \, \mu m \) are obtained. For each of the images \( S^{-1/2} \) is computed. The position of the in-focus image is calculated from the given three images and corresponds to \( d_4 = 0.3 \, \mu m \), which is within the tolerable defocus error for the given machine settings. The improvements of the image quality are visible in Figure 5. Different examples of our algorithm work for a particle analysis application can be found in [13].

V. DISCUSSION AND CONCLUSIONS

In this paper we have given a better insight into the analytical properties of the gradient-based sharpness function in the 2-D setting. It has been shown that the role of the artificial blur control variable \( \alpha \) in the higher dimension becomes more important due to the possible presence of astigmatism. If we only do the autofocus the proper choice of \( \alpha \) helps to avoid the multiple optima of the sharpness function. If we perform automated simultaneous defocus and astigmatism correction, by controlling \( \alpha \) we can improve the shapes of the sharpness function and increase the speed of optimization. Our results are implemented for real-world applications and deliver a satisfactory performance.

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